

General Description

It combines planar MOSFET technology with a low resistance package to provide low $R_{DS(ON)}$.

Features

- AEC-Q101 Qualified
- Low $R_{DS(ON)}$ to minimize conductive loss
- High GOX reliability
- Low Thermal resistance

Application

- BLDC Motor driver
- DC-DC
- Load Switch

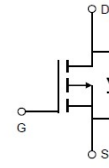
Ordering Information:

Part NO.	ZMPA02P50D
Marking	ZMP02P50
Packing Information	REEL TAPE
Basic ordering unit (pcs)	2500

Absolute Maximum Ratings ($T_C=25^\circ\text{C}$, unless otherwise specified)

Parameter	Symbol	Conditions	Min.	Max.	Unit
Drain-Source Voltage	V_{DS}		-	-500	V
Gate-Source Voltage	V_{GS}		-20	20	V
Continuous Drain Current	I_D	$V_{GS}=-10\text{V}, T_C=25^\circ\text{C}$	-	-4.7	A
	I_D	$V_{GS}=-10\text{V}, T_C=75^\circ\text{C}$	-	-3.8	A
	I_D	$V_{GS}=-10\text{V}, T_C=100^\circ\text{C}$	-	-3.3	A
Pulsed Drain Current	I_{DM}	Pulsed; $t_p \leq 10 \mu\text{s}; T_C = 25^\circ\text{C};$	-	-18.8	A
Total Power Dissipation	P_D	$T_C=25^\circ\text{C}$	-	167	W
Total Power Dissipation	P_D	$T_A=25^\circ\text{C}$	-	2.4	W
Operating Junction Temperature	T_J		-55	175	$^\circ\text{C}$
Storage Temperature	T_{STG}		-55	175	$^\circ\text{C}$
Single Pulse Avalanche Energy	E_{AS}	$L=5\text{mH}, V_{GS}=-10\text{V}, R_g=25\Omega,$	-	160	mJ
ESD Level (HBM)	CLASS 2				

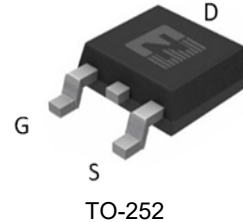
Product Summary



$$V_{DS} = -500\text{V}$$

$$R_{DS(ON)} = 3000\text{m}\Omega$$

$$I_D = -4.7\text{A}$$



•Thermal resistance

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal resistance, junction-case	R_{thJC}	-	-	0.9	°C/W
Thermal resistance, junction-ambient ^①	R_{thJA}	-	-	62	°C/W
Soldering temperature	T_{sold}	-	-	260	°C

•Electronic Characteristics (T_J=25°C,unless otherwise specified)

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V, I_D=-250\mu A$	-500	-	-	V
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS}=V_{DS}, I_D=-250\mu A$	-3	-4.3	-5	V
Drain-Source Leakage Current	I_{DSS}	$V_{GS}=0V, V_{DS}=-500V, T_J=25^\circ C$	-	-	-1.0	μA
		$V_{GS}=0V, V_{DS}=-500V, T_J=175^\circ C$	-	-	-100	μA
Gate- Source Leakage Current	I_{GSS}	$V_{GS}=\pm 20V, V_{DS}=0V$	-	-	± 100	nA
Static Drain-source On Resistance	$R_{DS(ON)}$	$V_{GS}=-10V, I_D=-2A, T_J=25^\circ C$	-	3000	3600	m Ω
		$V_{GS}=-10V, I_D=-2A, T_J=175^\circ C$	-	7123	-	m Ω
Forward Transconductance	g_{FS}	$V_{DS}=-20V, I_D=-2A$	-	4.3	-	S
Diode Forward Voltage	V_{FSD}	$V_{GS}=0V, I_{SD}=-2A$	-	-	-1.3	V

•Dynamic characteristics (T_J=25°C,unless otherwise specified)

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Input capacitance	C_{iss}	$f=1MHz, V_{DS}=-250V, V_{GS}=0V$	-	848	-	pF
Output capacitance	C_{oss}		-	30	-	
Reverse transfer capacitance	C_{rss}		-	4	-	
Gate Resistance	R_g	$f=1MHz, V_{GS}=0V$	-	10	-	Ω
Total gate charge	Q_g	$V_{DD}=-250V, I_D=-2A, V_{GS}=-10V$	-	15.6	-	nC
Gate - Source charge	Q_{gs}		-	4.8	-	
Gate - Drain charge	Q_{gd}		-	5.0	-	
Turn-ON Delay time	$t_{D(on)}$	$V_{GS}=-10V, V_{DS}=-250V, R_G=3.3\Omega, I_D=-2A$	-	16	-	ns
Turn-ON Rise time	t_r		-	73	-	ns
Turn-Off Delay time	$t_{D(off)}$		-	46	-	ns
Turn-Off Fall time	t_f		-	59	-	ns
Reverse Recovery Time	t_{rr}	$V_{DD}=-250V, dI_S/dt=100A/\mu s, I_S=-2A$	-	351	-	ns
Reverse Recovery Charge	Q_{rr}		-	1950	-	nC

Fig.1 Gate-source voltage as a function of gate charge; Typical values; $T_j=25^\circ\text{C}$

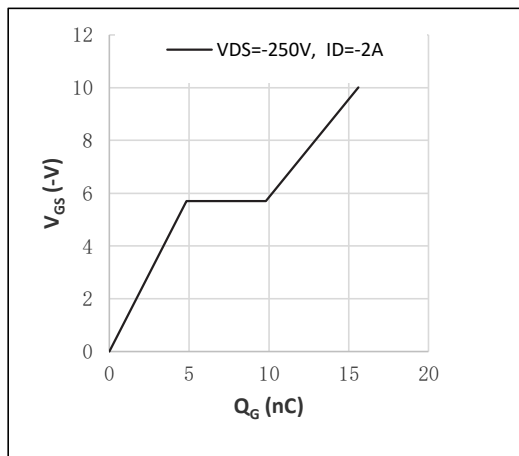


Fig.2 Input, output and reverse transfer capacitances as a function of drain-source voltage; Typical values; $T_j=25^\circ\text{C}$

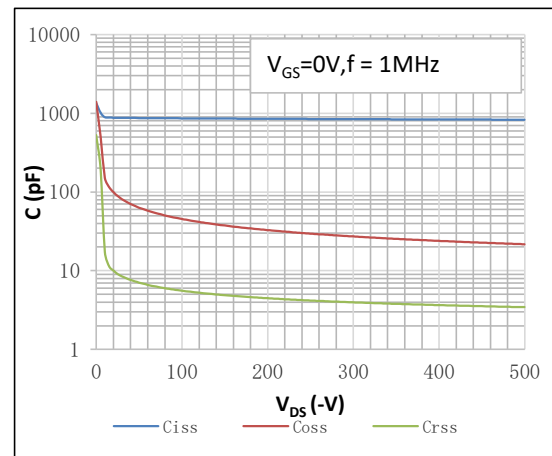


Fig.3 Output characteristics: drain current as a function of drain-source voltage; Typical values; $T_j=25^\circ\text{C}$

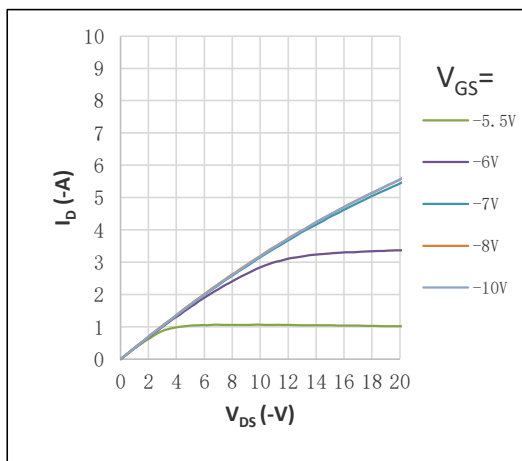


Fig.4 Output characteristics: drain current as a function of drain-source voltage; Typical values; Expanded curve; $T_j=25^\circ\text{C}$

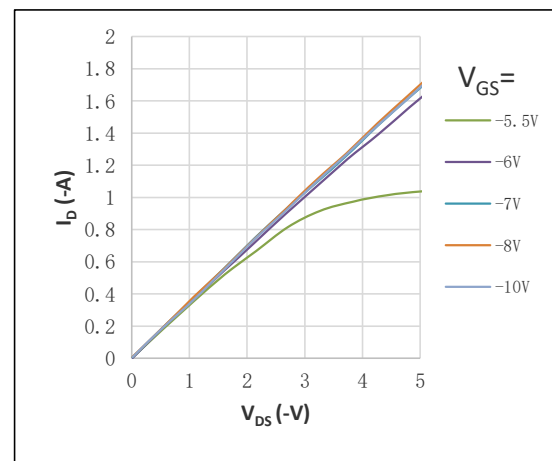


Fig.5 Gate-source threshold voltage as a function of junction temperature; Typical values

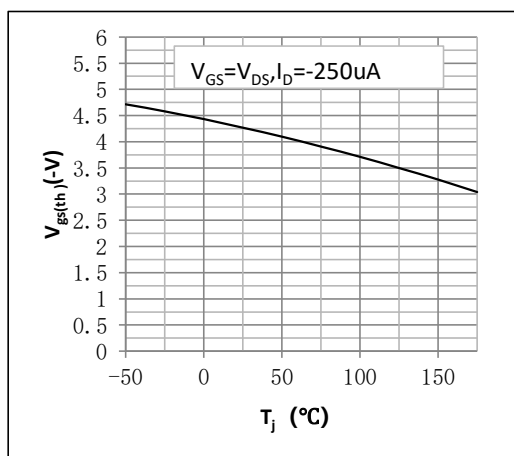


Fig.6 Drain-source on-state resistance as a function of drain current; Typical values; $T_j=25^\circ\text{C}$

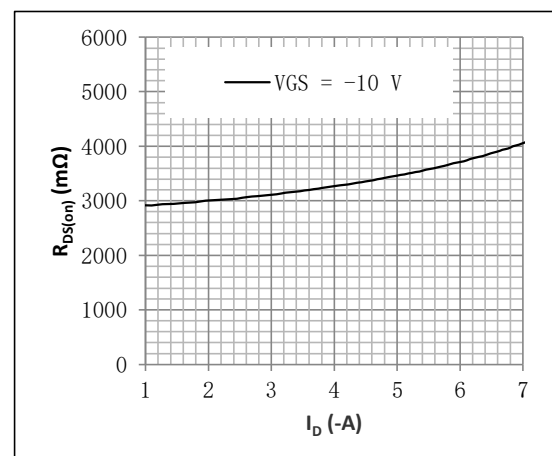


Fig.7 Drain-source on-state resistance as a function of gate-source voltage;Typical values

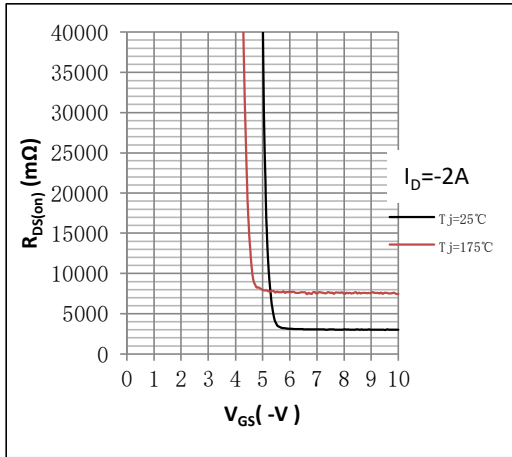


Figure 9. Source (diode forward) current as a function of source-drain (diode forward) voltage ;Typical values

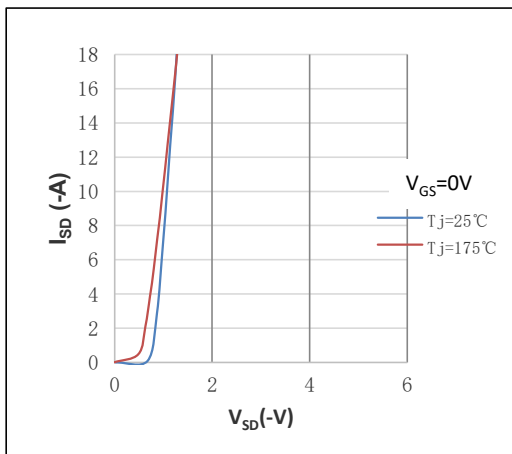


Fig.11 Safe operating area: continuous and peak drain currents as a function of drain-source voltage;Calculative values

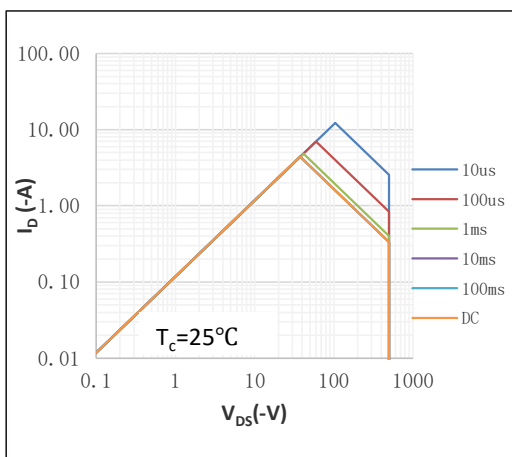


Fig.8 Normalized drain-source on-state resistance factor as a function of junction temperature;Typical values
Normalized On-Resistance= $R_{DS(on)}/R_{DS(on)}(25^{\circ}\text{C})$

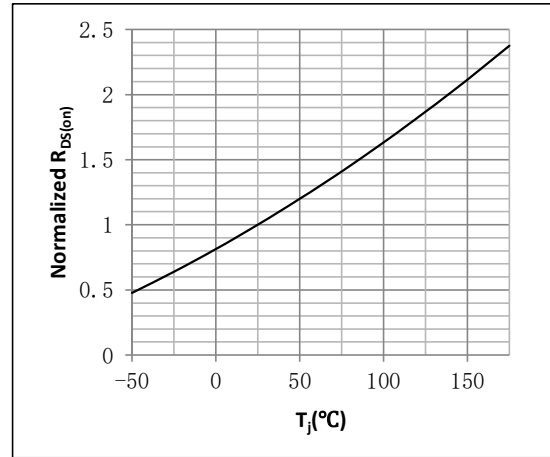


Figure 10. Transfer characteristics: drain current as a function of gate-source voltage;Typical values

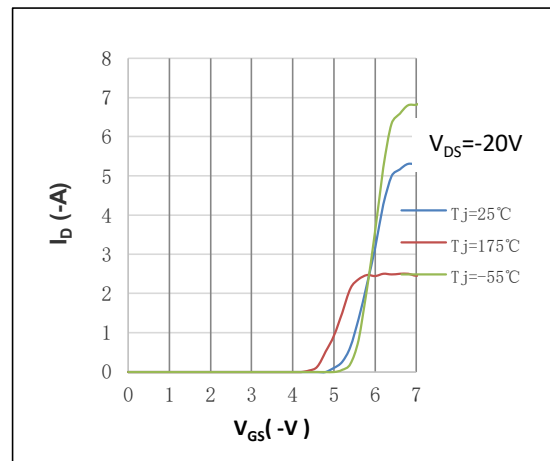


Fig.12 Continuous drain current as a function of case temperature[®];Calculative values

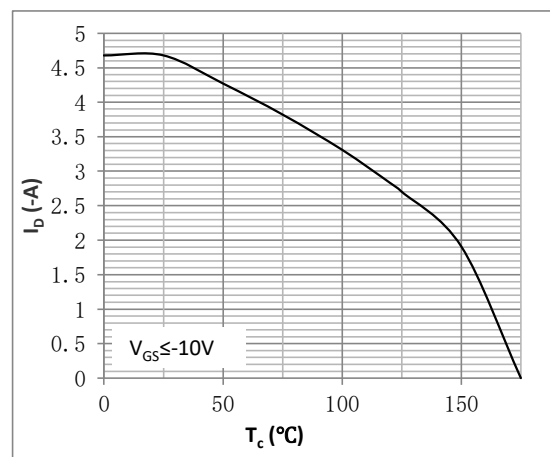


Fig.13 Drain-source breakdown voltage as a function of junction temperature; Typical values
Normalized BVDSS=BVDSS/BVDSS(25°C)

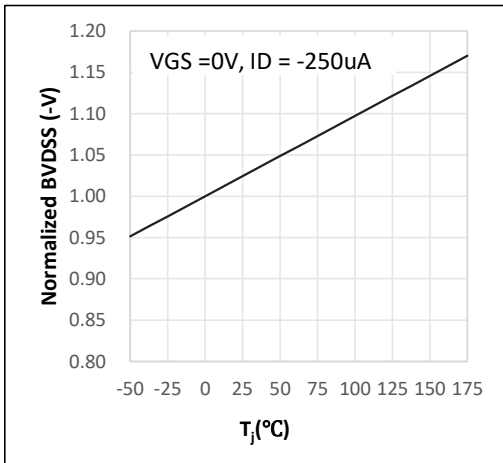


Fig.14 Normalized total power dissipation as a function of case temperature; Calculative values
Normalized Power Dissipation= $P_d/P_d(25^\circ C)$

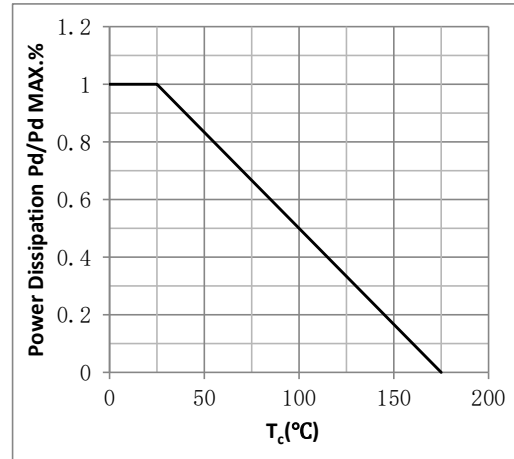
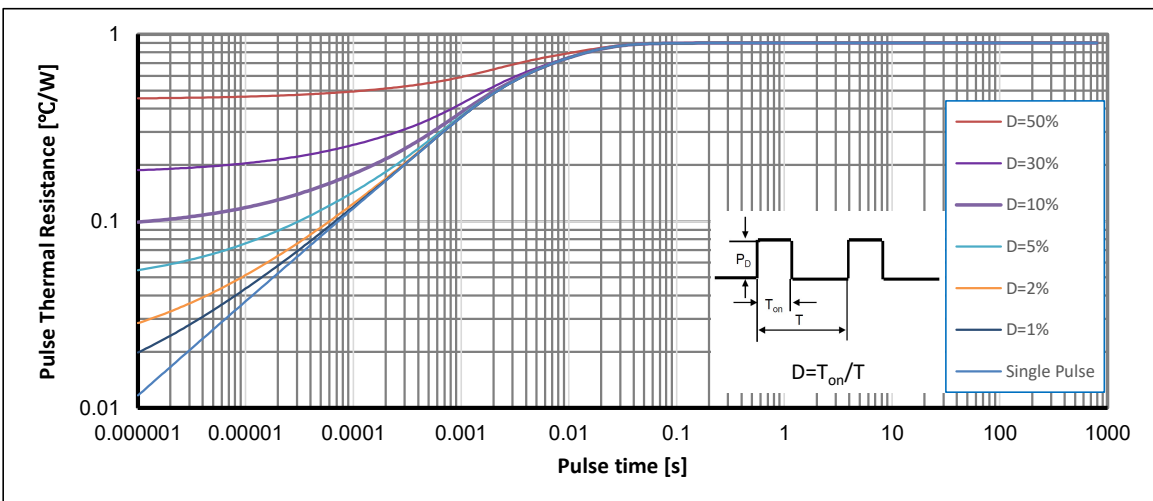
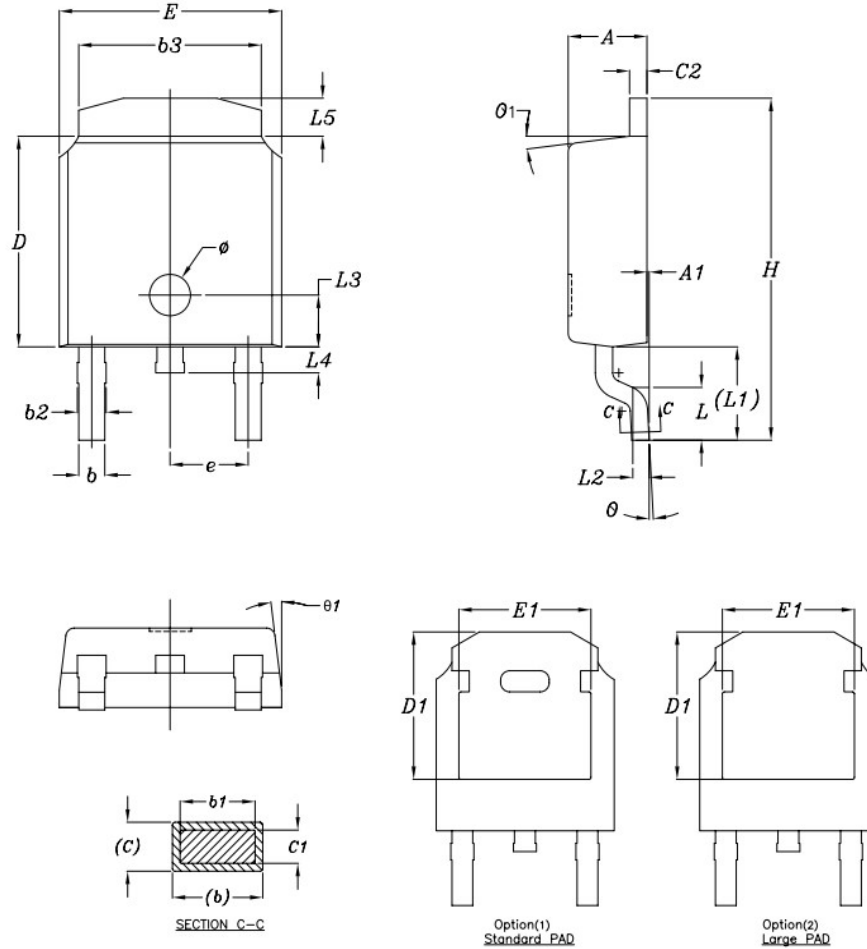


Fig.15 Transient thermal impedance from junction to case as a function of pulse duration; max values



•TO-252 Package Outline



I T E M	DIMENSIONS			
	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	2.18	2.39	0.086	0.094
A1	—	0.13	—	0.005
b	0.70	0.89	0.028	0.035
b1	0.70	0.86	0.028	0.034
b2	0.76	1.14	0.030	0.045
b3	4.95	5.46	0.195	0.215
c	0.46	0.61	0.018	0.024
c1	0.41	0.56	0.016	0.022
c2	0.46	0.89	0.018	0.035
D	5.97	6.22	0.235	0.245
D1	5.21	—	0.205	—
E	6.35	6.73	0.250	0.265
E1	4.32	—	0.170	—
e	2.29 BSC		0.090 BSC	
H	9.40	10.41	0.370	0.410
L	1.40	1.78	0.055	0.070
L1	2.60	2.90	0.102	0.114
L2	0.51 BSC		0.020 BSC	
L3	1.65	1.95	0.065	0.077
L4	0.60	0.90	0.024	0.035
L5	0.89	1.27	0.035	0.050
θ	1°	5°	1°	5°
θ	7° REF		7° REF	
ϕ	1.20 REF		1.20 REF	



Note:

- ① Device mounted on FR-4 substrate PC board, 2oz copper, with thermal bias to bottom layer 1inch square copper plate;
- ② Practically the current will be limited by PCB, thermal design and operating temperature. $V_{GS} = -10V$.

Disclaimer

- Reproducing and modifying information of the document is prohibited without permission from ZMJ SEMICONDUCTORS CO.,LTD.
- ZMJ SEMICONDUCTORS CO.,LTD. reserves the rights to make changes of the content herein the document anytime without notification. Please refer to our website for the latest document.
- ZMJ SEMICONDUCTORS CO.,LTD. disclaims any and all liability arising out of the application or use of any product including damages incidentally and consequentially occurred.
- ZMJ SEMICONDUCTORS CO.,LTD. does not assume any and all implied warranties, including warranties of fitness for particular purpose, non-infringement and merchantability.
- Applications shown on the herein document are examples of standard use and operation. Customers are responsible in comprehending the suitable use in particular applications. ZMJ SEMICONDUCTORS CO.,LTD. makes no representation or warranty that such applications will be suitable for the specified use without further testing or modification.
- The products shown herein are not designed and authorized for equipments relating to human life and for any applications concerning life-saving or life-sustaining, such as medical instruments, aerospace machinery et cetera. Customers using or selling these products for use in such applications do so at their own risk and agree to fully indemnify ZMJ SEMICONDUCTORS CO.,LTD. for any damages resulting from such improper use or sale.
- Since ZMJ uses lot number as the tracking base, please provide the lot number for tracking when complaining.

Revision History

Version	Date	Change
A	2025/6/21	New